

Upgrade your current instrument with microscopy capabilities

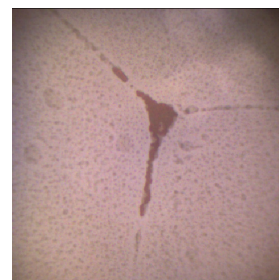
MicOS Microscope Optical Spectrometer

HORIBA Scientific's MicOS merges microscopy and spectroscopy, to provide optimal coupling from sample all the way to the detector. Down-looking or side-looking configurations for side-emitting devices or upright cryostats give you flexible sample access. An optional, fully automated stage for mapping and sample-positioning is available. The MicOS offers a flexible platform for the use of multiple lasers for sample excitation. The system includes a vision camera so you always see what you are measuring.

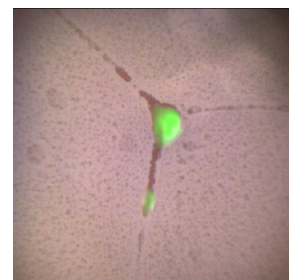


- Mount the MicOS micro-luminescence head directly onto any entrance ports of most HORIBA spectrometers
- Add micro-photoluminescence and micro-electroluminescence capabilities to your existing instrument
- Use multiple excitation sources, and measure luminescence from 200 nm to 1600 nm
- Enhance your instrument at a fraction of the cost of a brand-new microspectrometer

Photoluminescence



Aggregate of fluorescent beads

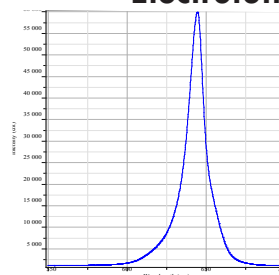


Fluorescence map overlay at 700 nm, following excitation at 633 nm

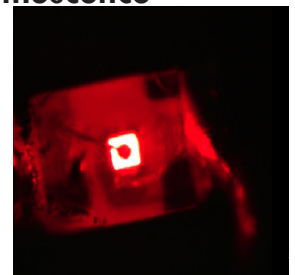
Specifications*

Spectrometers		iHR320		iHR550
Spectral range ¹		200 nm to 1600 nm		
Spectral resolution ²		0.18 nm		0.1 nm
Detector	Type	CCD 1024 × 256 OE ³	IGA 512 × 25	Single-channel
	Range	200–1050 nm	800–1600 nm	190–1600 nm ⁴
Excitation laser ⁵		532 nm	633 nm	785 nm
Microscope Objective	Magnification	10×	50×	100×
	Spot size	100 μm	<20 μm	<10 μm
Sample stage		xyz (manual or motorized)		

Electroluminescence



Emission of red LED



Red LED

¹Depends on choice of objective, filters, and detectors.
²For 1200 gr/mm grating and open-electrode CCD
³BIUV, BIVS, and BIDD formats available for specific quantum-efficiency requirements.
⁴Needs two detectors to cover entire range.
⁵Other options are available upon request.

*Specifications are subject to change without notice.

HORIBA

Scientific

ELEMENTAL ANALYSIS

FLUORESCENCE

GRATINGS & OEM SPECTROMETERS

OPTICAL COMPONENTS

FORENSICS

PARTICLE CHARACTERIZATION

RAMAN

SPECTROSCOPIC ELLIPSOMETRY

SPR IMAGING



Feature

Microspectroscopy Benefits

Fully integrated system	Optimum coupling from the sample all the way to the detector
Down-looking and side-looking configurations	Flexibility to measure luminescence from side-emitting devices and samples in upright cryostats
Multiple lasers	Can accommodate multiple fiber-coupled lasers for excitation at different wavelengths
Optional automated stage	Allows mapping functions and accurate sample-positioning
Vision camera included	See exactly what you are measuring
LabSpec Software	Complete control of an entire spectrograph system with full analysis capabilities
Wide spectral range	Collect emission spectra from 200 nm up to 1600 nm

info.sci@horiba.com
www.microspectroscopy.com

HORIBA
Scientific

USA: +1 732 494 8660
UK: +44 (0)20 8204 8142
China: +86 (0)21 6289 6060

France: +33 (0)1 69 74 72 00
Italy: +39 2 5760 3050
Brazil: +55 (0)11 5545 1500

Germany: +49 (0)89 4623 17-0
Japan: +81 (0)3 6206 4717
Other: +33 (0)69 74 72 00



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